## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination TANAKA ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0110104	06-2003	King et al.	705/28
*	В	US-5,615,109	03-1997	Eder, Jeff	705/8
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	1	US-			
	7	US-			
	К	US-		·	
	Ļ	US-			
	М	US-			,

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	·				
	0					
	Р					
	Q					,
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.